Notice of References Cited Application/Control No. 10/565,528 Applicant(s)/Patent Under Reexamination GRANT, JON Examiner MARINA TIETJEN Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,764,102 A	10-1973	Shopsky, Harvey J.	251/96
*	В	US-3,777,771 A	12-1973	De Visscher, Patrick M.	137/1
*	С	US-2002/0117645 A1	08-2002	Kiehne, Bruce Leigh	251/149.6
*	D	US-6,497,348 B2	12-2002	Forsman et al.	224/148.2
*	Е	US-6,908,015 B2	06-2005	Choi et al.	222/175
*	F	US-2006/0054643 A1	03-2006	Wheaton, Christopher Simon Courtenay	222/400.7
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	C						
	>						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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